Beam Dynamics Measurements with New Generation BPMs



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BES Light Sources Beam Stability Workshop, ALS, LBNL

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Motivation

Why (electron) beam dynamics at Beam Stability Workshop?

- Majority of users are happy with present stability levels.
- Looking into the future: diffraction-limited light sources with tiny beams.
- Plan on running above collective instability thresholds (counting on selfstabilizing or feedback-controlled instabilities).
- Understanding collective and nonlinear single-particle dynamics and, increasingly, their interplay, is crucial for stably running an advanced light source.
- Sophisticated measurements are need to confirm/refine machine model.
- Some of these measurements are done at low current, non-standard fill patterns and without feedbacks. Stability is often a limitation.
- Beam dynamics is reach and exciting subject.

Outline and References

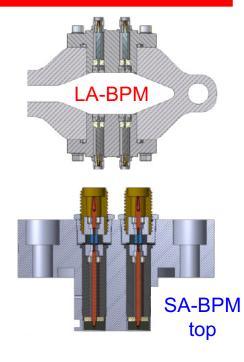
- A bit about NSLS-II BPMs
- How these enable delicate beam dynamics measurements
- Measurement examples
- Conclusions

- B. Podobedov, W. Cheng, K. Ha, Y. Hidaka, J. Mead, O. Singh, K. Vetter, IPAC2016, WEOBB01
- B. Podobedov, W. Cheng, Y. Hidaka, D. Teytelman, IBIC2016, TUCL02
- Y. Hidaka, W. Cheng, B. Podobedov. NAPAC2016, MOA2C003

NSLS-II BPM Pickups

- NSLS-II: 30 cell DBA 3 GeV ring with 1 nm / 8 pm design emittances, smallest beam size 3 μm rms (y)
- Beam stability of paramount importance for users
- NSLS-II is equipped with a large number of highperformance BPMs (~240 at present)

RF BPM Types	Quantity
Multi-Pole Chamber BPMs (LA)	6 per cell
<u>L</u> arge <u>A</u> perture (25 mm vert.)	180 Total
Insertion Device (ID) Chamber BPMs (SA)	2-4 per ID
<u>S</u> mall <u>Aperture</u> (8-11.5 mm vert.)	straight
	~30 Total (now)
Special BPMs (injection, BxB fdbk, test,)	~10





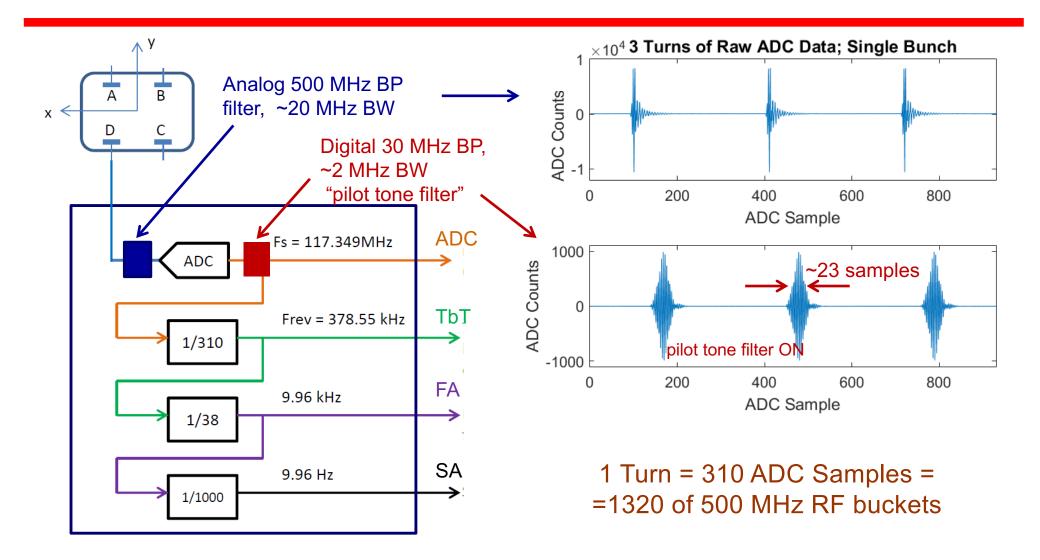
Real SA button assemblies are rotated around the vertical

NSLS-II BPM Receivers

Data Type	Mode	Max Length
ADC Data	On-demand	256Mbytes or 32M samples per channel simultaneously
Turn-by-Turn (TbT), Frev=379 kHz	On-demand	256Mbytes or 5 M samples Va,Vb,Vc,Vd, X,Y,SUM, Q, pt_va,pt_vb,pt_vc,pt_vd
Fast Acquisition (FA) , 10KHz	Streaming via SDI Link & on demand	Streaming - X,Y,SUM; For on demand: 256 Mbytes or 5 Msamples. Va,Vb,Vc,Vd, X,Y, SUM, Q, pt_va,pt_vb,pt_vc,pt_vd
Slow Acquisition (SA), 10Hz	Streaming and On-demand	80hr circular buffer Va,Vb,Vc,Vd, X,Y,SUM, Q, pt_va,pt_vb,pt_vc,pt_vd

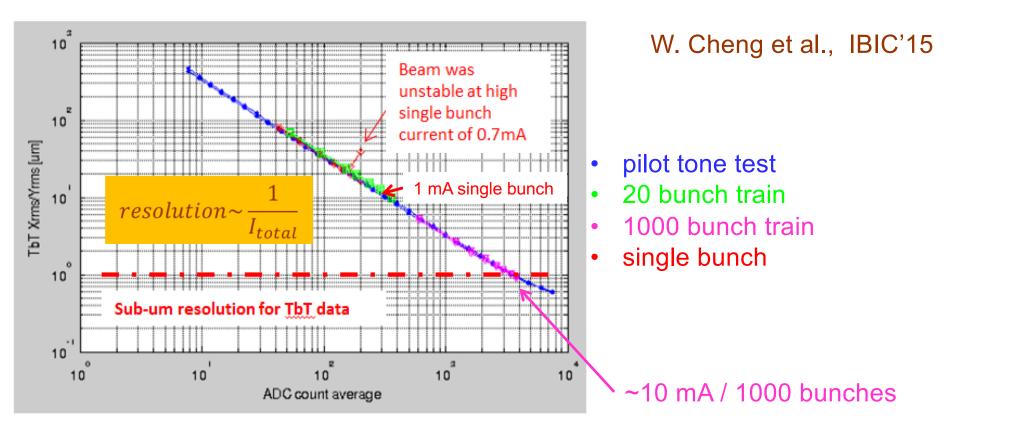
- Original NSLS-II development (by Kurt Vetter et al.)
- Resolution specs of 1 μm turn-by-turn (TbT) and 200 nm in 10 kHz (FA) mode were verified with beam
- TbT used for injection & kicked beam studies, FA for fast orbit feedback & interlocks, SA for orbit measurements
- Recently added bunch-by-bunch capability (to resolve bunches within a turn) Boris Podobedov, Beam Stability Workshop 2018

NSLS-II BPM Signal Processing



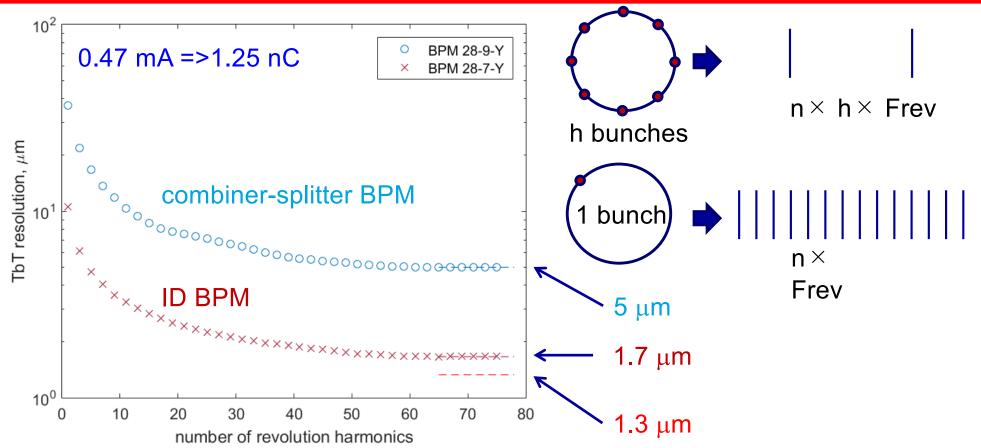
• TbT X, Y, and Σ are obtained (in FPGA for Ops, or Matlab for studies) from ADC signals by coherent signal processing locked to revolution harmonic.

NSLS-II BPM Turn-by-Turn Resolution



- Sub-micron TbT resolution is routinely available for long bunch trains
- However, single bunch resolution was 1-2 magnitude orders worse
- It was recently improved [B. Podobedov et. al., IPAC'16] by order of magnitude plus BPM capabilities were enhanced to resolve multiple bunches within a ring turn

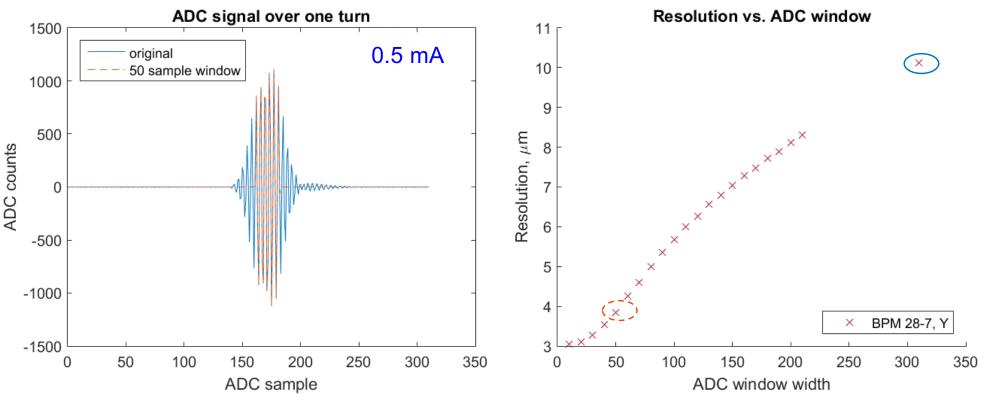
Resolution Improvement by Including Multiple Revolution Harmonics



- Without pilot tone filter the number of in-band harmonics is higher =>resolution improvement of about factor of 7.
- On ID BPMs directly measured resolution reaches 1.7 μm, or 1.3 μm when scaled from combiner-splitter BPM.

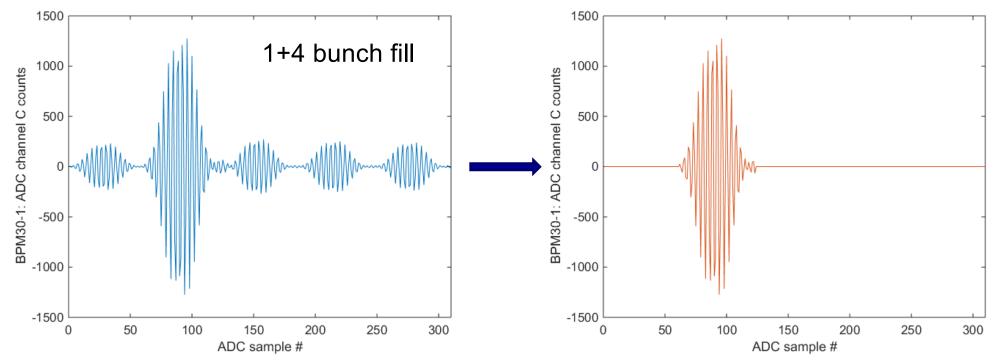
Resolution Improvement by Gating BPM ADC Signals

- Standard BPM processing looks at all 310 ADC channels (i.e. entire turn)
- Let's use only the ADC channels that contain most of the single bunch signal (i.e. apply a boxcar window on every turn)



This results in resolution improvement by factor of 3 to 4.

From Gating ADC Signals to Resolving Individual Bunches within a Turn



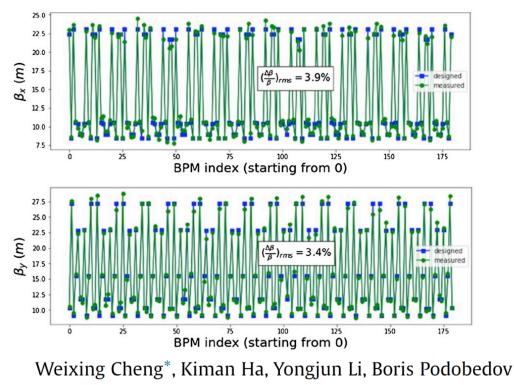
- Gate-out signals from all but one bunch (on every turn)
- Include enough harmonics of Frev
- Use standard processing to extract X, Y, Σ from these modified ADC data
- Repeat for each bunch
- We can resolve up to 8 bunches, depending on experiment

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We can resolve few separate bunches on every turn, with good resolution, so what?

- This enables precise beam dynamics measurements
- Two examples to follow:
 - Tune shift with current (for collective effects)
 - Tune shift with amplitude (for single-particle dynamics)
- Many other applications, incl. some that directly benefit stability =>

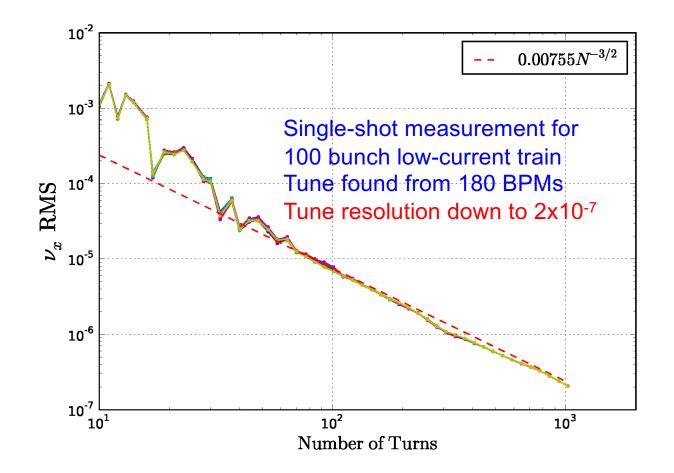
Lattice functions measured from camshaft bunch with user beam in the ring



MethodsX 5 (2018) 626-634

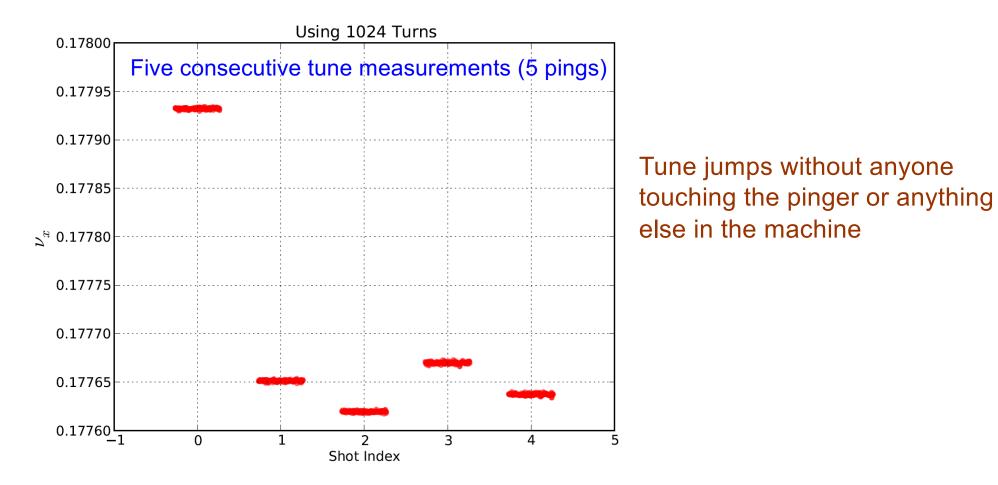
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~10⁻⁷ Tune Resolution has been Demonstrated



But only for a single-shot (and low-current bunch train)

Shot-to-Shot Tune Stability is Much Poorer



- At NSLS-II typical (shot-to-shot) tune jitter is >10-4 (rms)
- This would normally preclude any sensitive measurements that rely on better tune resolution (including impedance)

Shot-to-Shot Tune Jitter is a Common Obstacle for Impedance Measurements

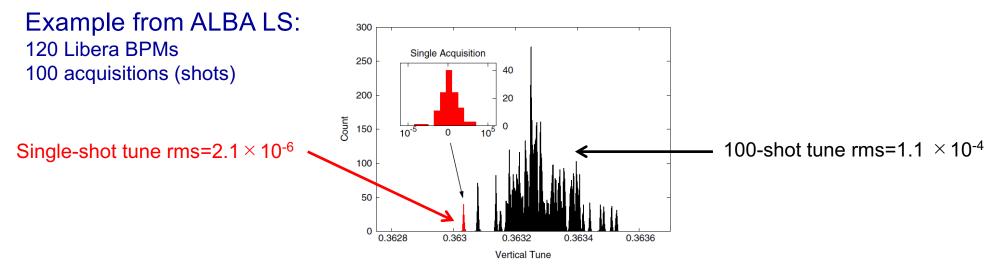


FIG. 3. Histogram of the vertical tune measured by 120 BPMs for 100 acquisitions. The measurement shows an overall standard deviation of 1.1×10^{-4} , on the other hand looking at one single acquisition (in red) the spread is strongly reduced presenting a standard deviation of only 2.1×10^{-6} .

PHYSICAL REVIEW ACCELERATORS AND BEAMS 19, 121002 (2016)

Local transverse coupling impedance measurements in a synchrotron light source from turn-by-turn acquisitions

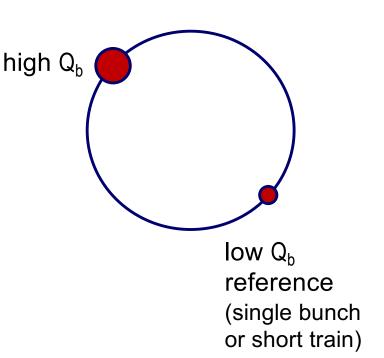
Michele Carlà, Gabriele Benedetti, Thomas Günzel, Ubaldo Iriso, and Zeus Martí ALBA-CELLS Synchrotron Radiation Facility, Carrer de la Llum 2-26, 08290—Cerdanyola del Valles, Barcelona, Spain (Received 13 June 2016; published 19 December 2016)

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How to Overcome Tune Jitter and Drifts for Impedance Measurements

Use a reference measurement: simultaneously kick, record turn-by-turn BPM positions, then calculate the tunes of two (or more) bunches stored in the ring. Tune difference gives Z.

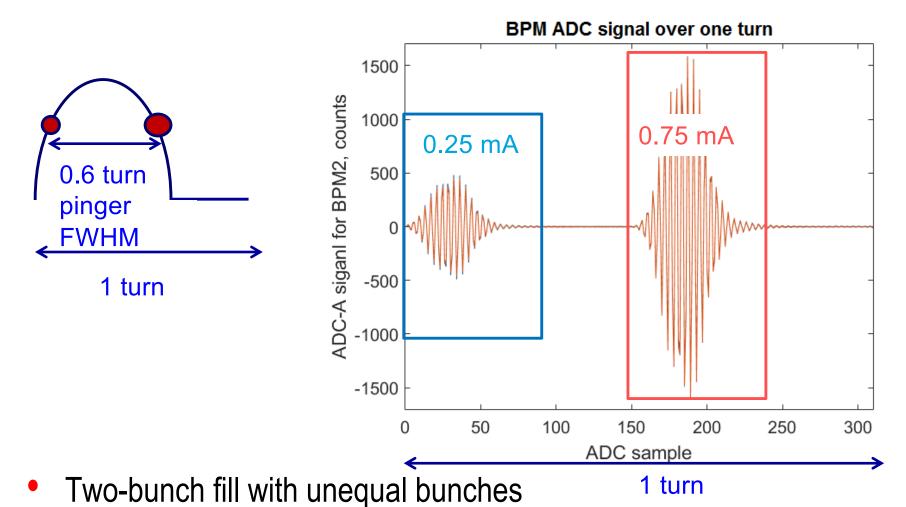
- Must have high-resolution BPMs that are capable of accurate tune measurements.
- Better to have many of these BPMs, to improve the resolution further.
- BPMs must capable of resolving turn-byturn positions of two (or more) individual bunches, with low-current bunch(es) used as a reference.



$$\delta k_{kick} = 4\pi \delta (v_{lowQ_b} - v_{hiQ_b}) \frac{E/e}{\Delta Q_b < \beta >}$$

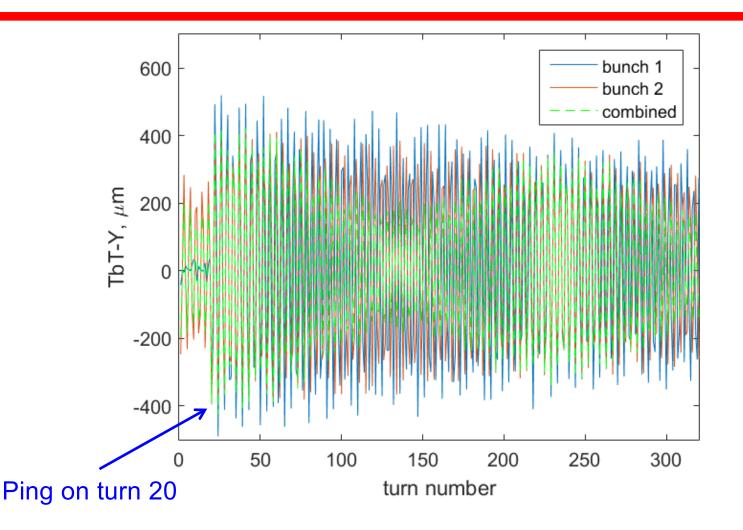
NSLS-II has BPMs that make this possible

Unequal Charge Bunches Kicked with a Pinger



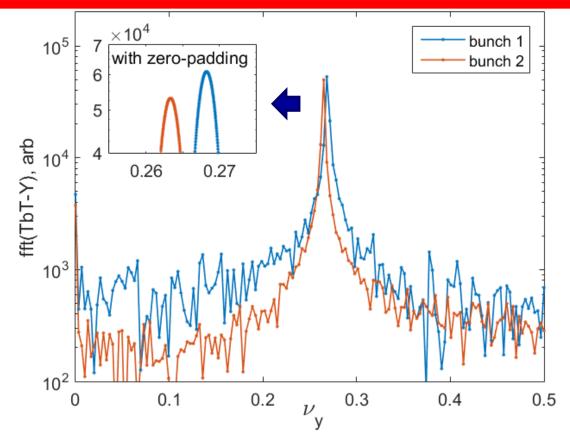
- Pinger timing adjusted for equal vertical kick
- ADC data processed to get turn-by-turn positions for each bunch

Turn-by-Turn Signals



- Each bunch decays a long time, but the combined shows beating
- Also instability for high current bunch before the ping

Vertical Tunes are Distinctly Different

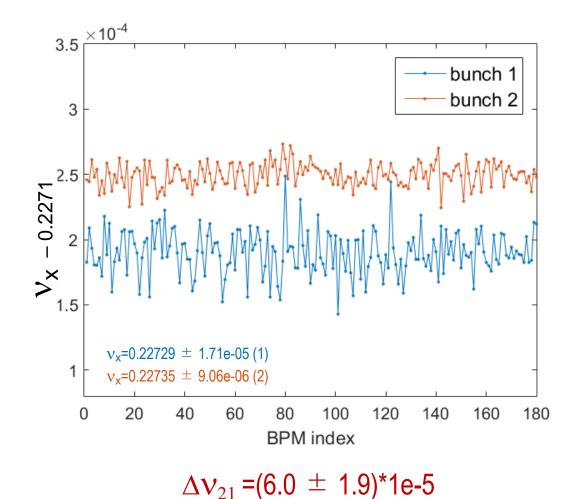


- Single BPM FFT shows tunes are clearly unequal
- Detailed analysis with interp'd FFT for 180 BPMs gives v_v =0.26833 ± 1.93e-5 (bunch 1) and v_v =0.26334 ± 6.90e-6 (bunch 2)
- Tune difference of $\Delta v_{21} = -5e-3/(0.5 \text{ mA}) = -0.01/\text{ma}$ agrees with measurements by other methods

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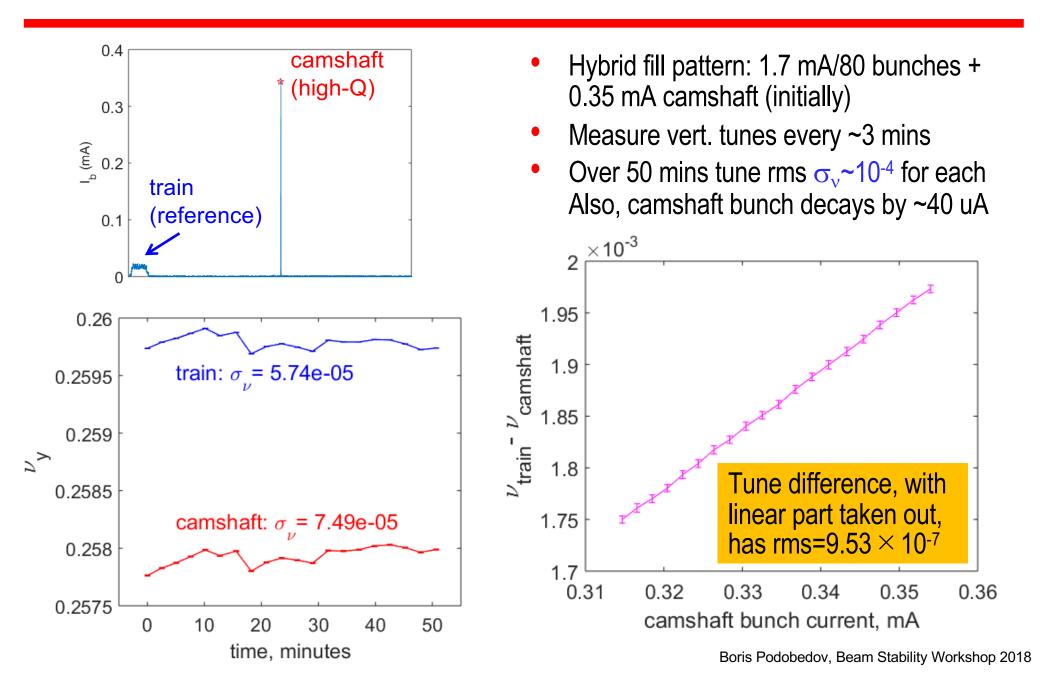
Same Measurement in the Horizontal

- Same two bunches, 0.25 mA (1) and 0.75 ma (2)
- Use horizontal pinger
- BPM ADC data processed to get separate TbTs for each bunch
- Use 25 revolution harmonics to increase the resolution



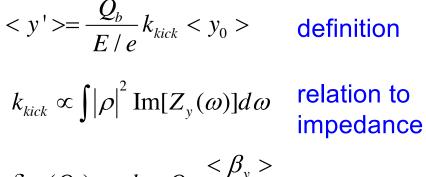
 This measurement convincingly shows that horizontal tune goes up with current (i.e. total wake is slightly focussing).

10⁻⁶ Tune Difference Resolution Achieved



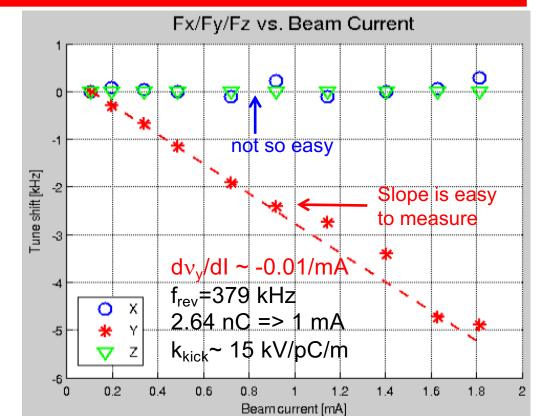
From Tune Measurement to Coupling Impedance

Kick factor:



$$\delta v_y(Q_b) = -k_{kick}Q_b \frac{\langle P_y \rangle}{4\pi E/e}$$

relation to tune shift with current



If we could resolve tunes to 10⁻⁶

$$\delta k_{kick} = 4\pi \delta (v_{lowQ_b} - v_{hiQ_b}) \frac{E / e}{\Delta Q_b < \beta > 0}$$

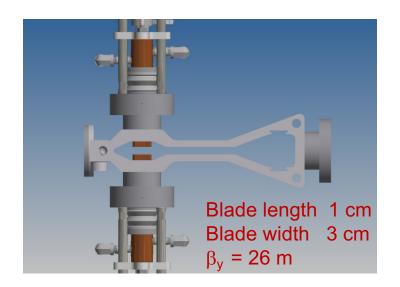
then we get kick factors as low as 10 V/pC/m assumed 1 nC, < β >=4 m, 3 GeV 10 V/pC/m is a RW kick factor of a 1 m long AI pipe 12 mm in diameter (σ_z =5 mm)

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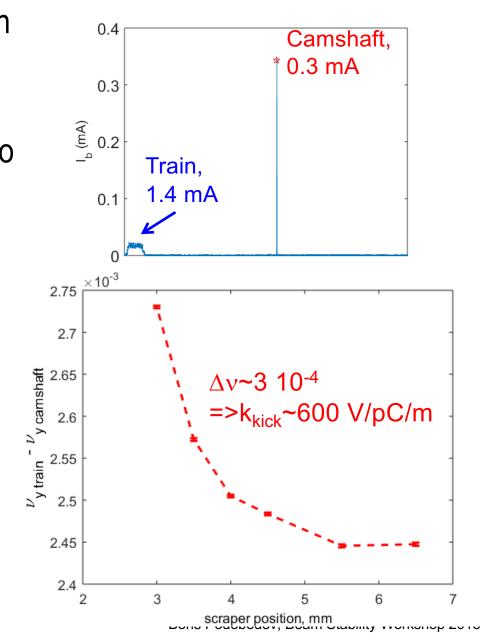
Measurement Examples

Local Impedance Measurement: Vertical Scraper

- Measure tune difference high-Q bunch vs. reference train (low-Q / bunch)
- Repeat with the scraper inserted
- Change in the tune difference is due to added scraper impedance

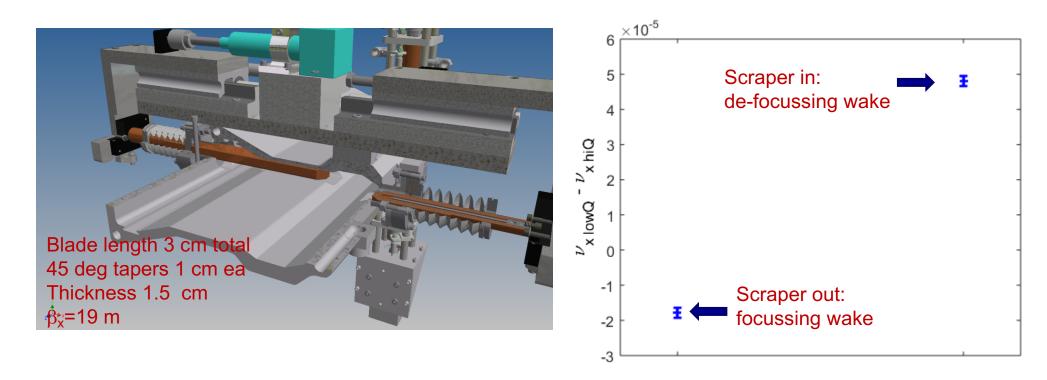


 Complimentary measurement would be from closed orbits (no kick), TBD



Horizontal Scraper

- Two bunches stored, inner blade moved in
- Change in the tune difference is due to (added) scraper impedance



 With scraper blade close to the beam, tune-current slope changes to negative (agrees with expectation)

Measure Low-β Insertion Device Chamber

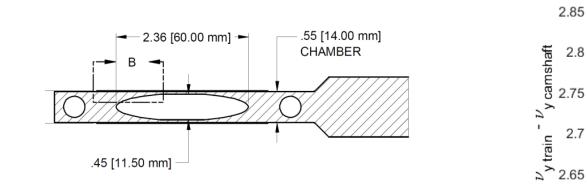
- Example of a fixed impedance component, use local bumps to probe Z
- Cell 21 has two EPUs (out-of-vacuum)
- Vacuum chamber is Al pipe, 4.8 m length, β_{v0} =1.2 m, resistive wall is dominates, RW kick factor 56 V/pC/m at σ_{τ} (0.3mA)=16.2 ps measured separately 2.9 × 10⁻¹

2.85

2.6

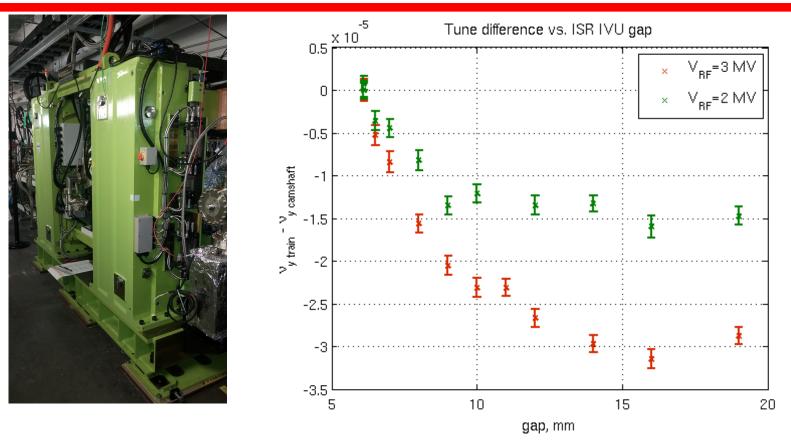
-2

0 C21 bump, mm 2



- Injected 1.4 mA train + 0.3 mA camshaft
- 2.55 Camshaft decayed some during the bumps
- Measured kick factor of 210 V/pC/m tune is about x4 higher than the theory for AI but is likely due to NEG coating and addl'I taper impedance Boris Podobedov, Beam Stability Workshop 2018

ISR In-Vacuum Undulator Tunehifts vs. Gap

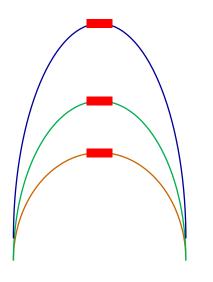


- Performed on C4-ID (ISR, IVU23, L=2.8 m). Tune difference between the train and camshaft bunches measured vs. gap.
- ~10⁻⁶ tune relative tune resolution easily achieved at <1000 turns, 0.3 mA camshaft bunch current.
- Effect is smaller for longer bunch, as expected.

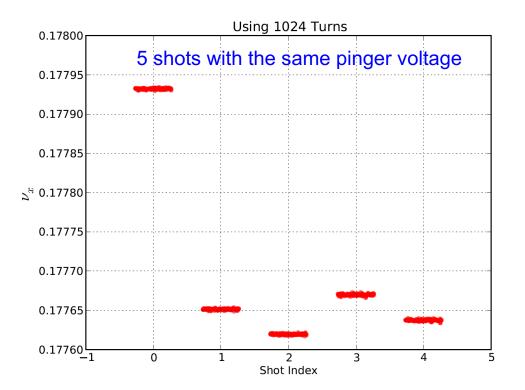
Measurement of Tune Shift with Amplitude

Conventional measurement:

- •Use short bunch train at low current
- •Vary pinger voltage
- •Record multiple TbT data sets

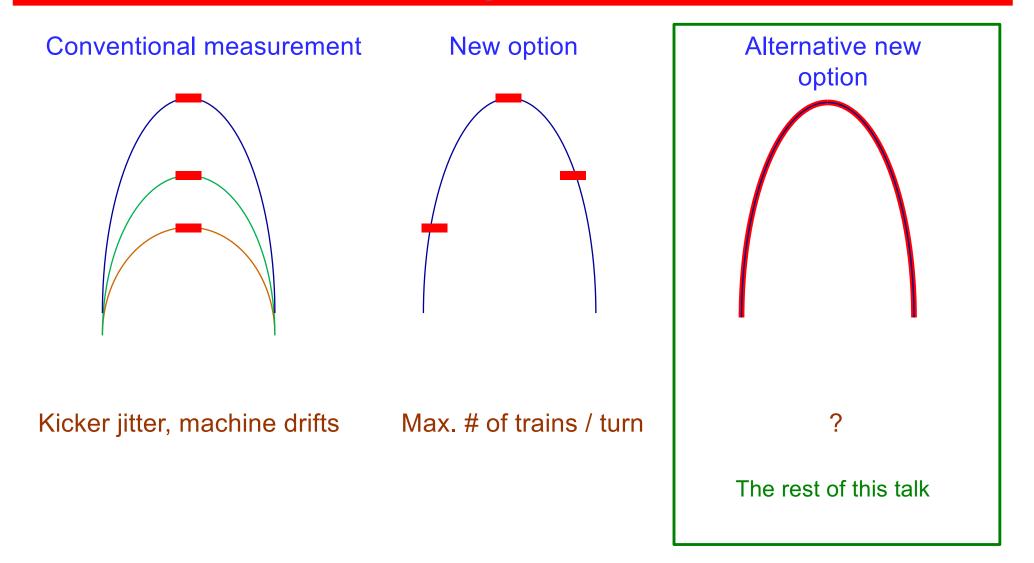


Issues: kicker jitter, machine drifts



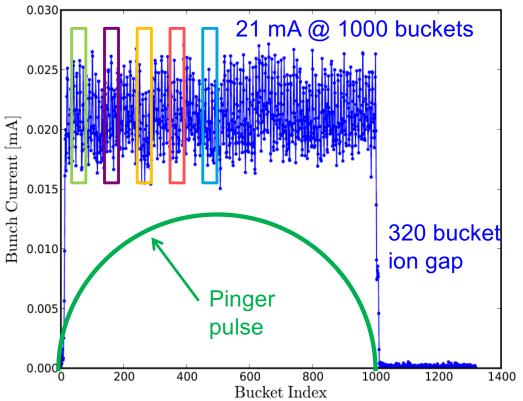
Shot-to-shot tune jitter

Single Shot Measurement of Tune Shift With Amplitude



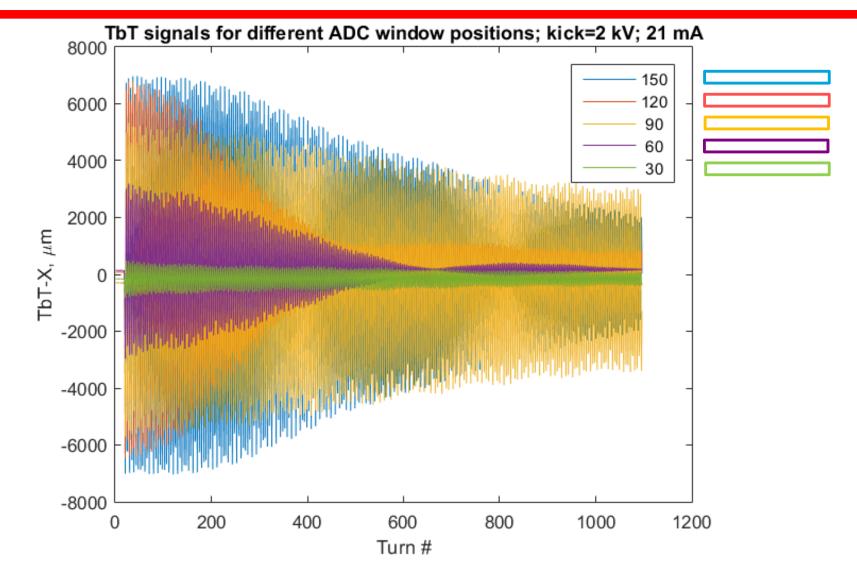
Measurement Setup

• Fairly uniform fill pattern at low current (no collective effects !)



- Adjust pinger timing to center maximum kick in the middle
- 11 sample wide ADC window (~47 RF buckets); slide over the turn
- Results independent of window width when it's << kicker rise time

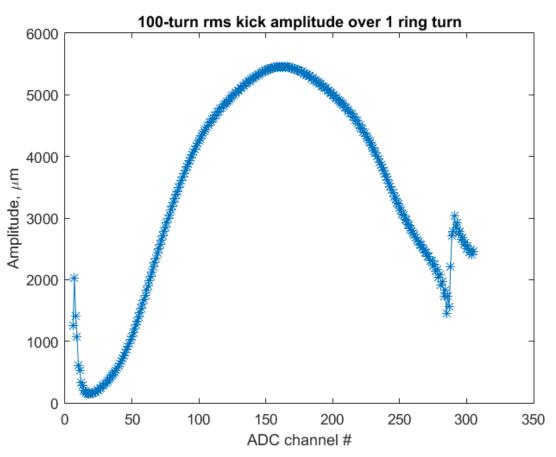
TbT Signals from Selected ADC Bins



- Induced amplitudes vary according to bin position wrt. pinger
- Short chunks of the bunch train can be resolved! Boris Podobedov, Beam Stability Workshop 2018

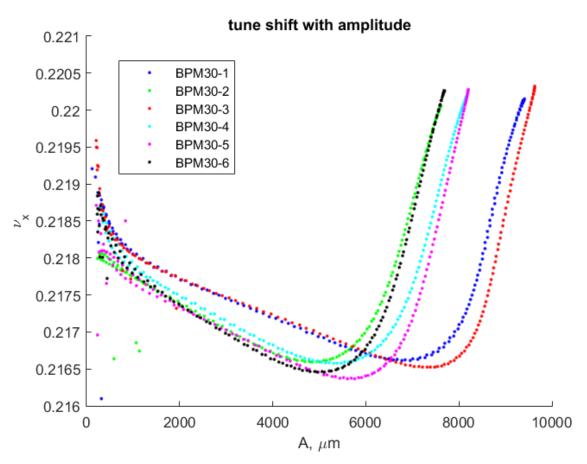
Amplitudes for All ADC Bins Together

• Recover the shape of pinger pulse



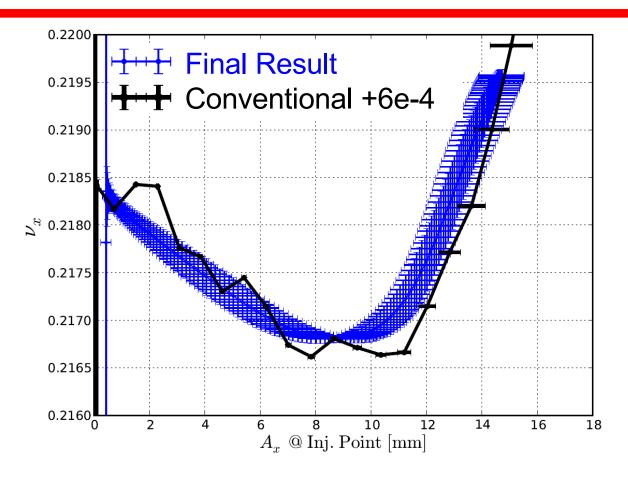
Except at the head (there is no kick) and near the ion gap

Tune Shift with Amplitude: 6 BPMs



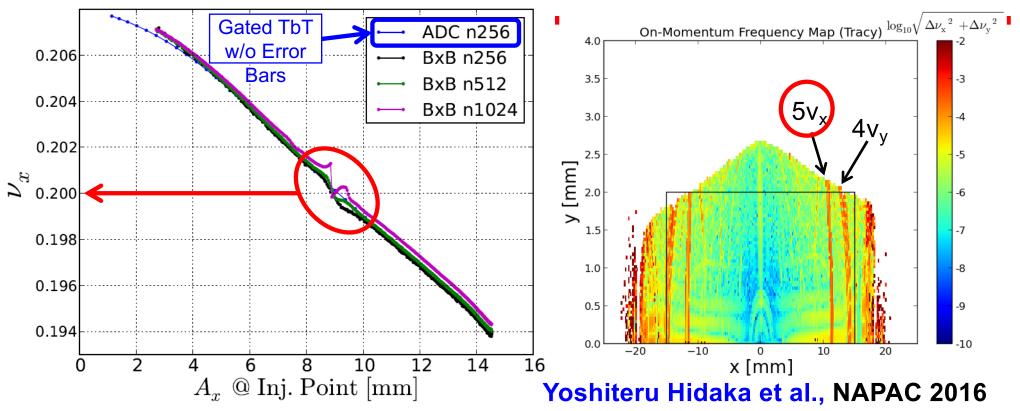
- Smooth curves except at very low amplitudes
- Other cells look very similar
- From here: scale to injection point; error-bars from all 180 BPMs

Final Results: Horizontal



- Final result for 5mA/1000 bunches, single pulse of 2 kV ("bare" lattice)
- Conventional measurement: 2 mA/100 bunches; 20 separate "pings"; clear pulse-to-pulse jitter, longer term drifts are likely
- Further optimization of new technique possible

Example of Further Optimized Measurement



- "3 DW" lattice
- Gated turn-by-turn 180 BPMs for amplitude, BxB feedback for tune
- Distortion around $v_x = 0.2$ (5 v_x resonance) from BxB (more pronounced with more number of turns used for tune extraction)
- Simulated frequency map analysis (w/ engineering tolerance) predicted this resonance!

Conclusions

- State-of-the-art NSLS-II BPM receivers enable advanced beam dynamics measurements.
- For instance, we can resolve the tunes of several individual bunches stored in the ring with very high accuracy. 10⁻⁶ tune resolution has been demonstrated.
- This enables a fast and precise technique for measuring the transverse impedance (kick factor) of storage ring elements.
- This reference technique eliminates harmful effects of machine drifts. It also eliminates other large systematic effects, unrelated to the impedance, i.e. singe particle tune change due to undulator gap closure.
- Another useful application is for single-shot measurements of tune-shift with amplitude. Many more were not mentioned in this talk.
- BPM signal processing for the examples presented in this talk was done off-line but it is being implemented in FPGA. This should greatly speed up these measurements as well as enable orbit-based Z-measurements.

Acknowledgements

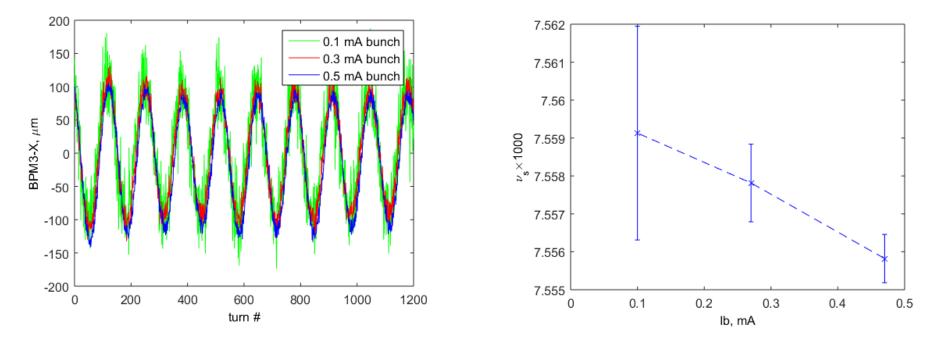
I would like to acknowledge the enormous help I received from many present and NSLS-II colleagues but especially from

Weixing Cheng and Yoshi Hidaka (physics), Kiman Ha, Joe Mead, Om Singh, Kurt Vetter (diagnostics), as well as from Dmitry Teytelman, from Dimtel, (everything)



Synchrotron Tune Shift with Current

- RF cavity feedforward provides short (<1/f_s) RF amplitude jump
- Beam (3 bunches, 1/3 ring apart each) is kicked longitudinally, synchrotron tune detected on dispersive BPMs (60 total)



 As expected, tune change with current is miniscule (imperfect cancellation of coherent and incoherent tuneshifts), yet measurable to be around 10⁻⁵/mA with this method ...